# Notice of References Cited Application/Control No. 10/522,314 Examiner HILINA S. KASSA Applicatit(s)/Patent Under Reexamination ONO, TAKASHI Page 1 of 2

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,641,133 A	02-1987	Ono, Takeshi	340/540
*	В	US-4,719,514 A	01-1988	Kurahayashi et al.	358/426.05
*	С	US-4,897,831 A	01-1990	Negi et al.	370/249
*	D	US-5,075,783 A	12-1991	Yoshida et al.	358/439
*	Е	US-5,216,705 A	06-1993	Yoshida et al.	379/100.14
*	F	US-5,394,406 A	02-1995	Ono et al.	714/748
*	G	US-5,987,494 A	11-1999	Ouchi, Tetsuya	718/107
*	Ι	US-6,247,057 B1	06-2001	Barrera, III, Joseph S.	709/229
*	ı	US-6,288,790 B1	09-2001	Yellepeddy et al.	358/1.15
*	J	US-2003/0101236 A1	05-2003	Ohara, Kiyotaka	709/218
*	K	US-2003/0105841 A1	06-2003	Miyake et al.	709/220
*	L	US-2003/0142683 A1	07-2003	Lam et al.	370/401
*	М	US-2003/0220900 A1	11-2003	Gabor, Bajko	707/1

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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### **NON-PATENT DOCUMENTS**

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# Notice of References Cited Application/Control No. 10/522,314 Examiner HILINA S. KASSA Applicant(s)/Patent Under Reexamination ONO, TAKASHI Page 2 of 2

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,934,932 B2	08-2005	Dathathraya, Sridhar	717/115
*	В	US-7,031,276 B2	04-2006	Inoue, Atsushi	370/328
*	С	US-7,155,500 B2	12-2006	Nikander, Pekka	709/223
*	D	US-7,185,074 B2	02-2007	Schacht et al.	709/221
*	Е	US-7,257,104 B2	08-2007	Shitama, Kazuhiro	370/338
*	F	US-7,266,601 B2	09-2007	Maekawa et al.	709/224
*	G	US-7,264,411 B2	09-2007	Matsunaga et al.	400/62
*	Ι	US-7,308,495 B2	12-2007	Ishiyama et al.	709/223
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.